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03/17/00**APPLICATION ELEMENTS**

See MPEP chapter 600 concerning utility patent application contents.

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Box Patent Application
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1. ☒ Fee Transmittal Form
2. ☒ Specification, Claims & Abstract [Total Pages: 25]
3. ☒ Drawing(s) (35 USC 113) [Total Sheets: 10]
4. ☒ Oath or Declaration [Total Pages: 3]
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 - b. ☐ Copy from a prior application (37 CFR 1.63(d)) (for continuation/divisional with Box 17 completed)
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Signed statement attached deleting inventor(s) named in the prior application, see 37 CFR 1.63(d)(2) and 1.33(b).
5. ☐ Incorporation by Reference (usable if Box 4b is checked)
The entire disclosure of the prior application, from which a copy of the oath or declaration is supplied under Box 4b, is considered as being part of the disclosure of the accompanying application and is hereby incorporated by reference therein.
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ACCOMPANYING APPLICATION PARTS

8. ☒ Assignment Papers (cover sheet & document(s))
9. ☐ 37 CFR 3.73(b) Statement (when there is an assignee) [] Power of Attorney
10. ☐ English Translation Document (if applicable)
11. ☐ Information Disclosure Statement (IDS)/PTO-1449 [] Copies of IDS Citations
12. ☐ Preliminary Amendment
13. ☒ Return Receipt Postcard (MPEP 503) (Should be specifically itemized)
14. ☐ Small Entity Statement(s) [] Statement filed in prior application, status still proper and desired.
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17. If a CONTINUING APPLICATION, check appropriate box and supply the requisite information:[] Continuation [] Divisional [] Continuation-in-part (CIP) of prior application No: / **18. CORRESPONDENCE ADDRESS**STAAS & HALSEY LLP
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SPECIFICATION

TO ALL WHOM IT MAY CONCERN:

BE IT KNOWN THAT WE, Shinkichi Gama, a citizen of Japan residing at Yokohama-shi, Kanagawa, Japan and Shogo Shibazaki, a citizen of Japan residing at Yokohama-shi, Kanagawa, Japan have invented certain new and useful improvements in

STORAGE DEVICE

of which the following is a specification : -

STORAGE DEVICE

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35 Further, an authentication is processed
based on cipher text by using a shared cipher key
between the non-volatile memory and a host device for

use thereof.

Disadvantageously, in this case, when the cipher key is read, a host device used by the illegal user can obtain data from the non-volatile memory by
5 utilizing the test terminal.

Accordingly, the test terminal is not conventionally provided for the non-volatile memory so as to prevent a cipher key or secret data from being stolen by utilizing the test terminal and the
10 test function.

In the above conventional non-volatile memory, illegal users' infringement can be prevented and high security can be maintained.

However, makers manufacturing conventional
15 non-volatile memories can not properly test fully assembled non-volatile memory to ensure the quality thereof.

In the conventional manner, it is difficult to improve the quality of the non-volatile
20 memory.

SUMMARY OF THE INVENTION

It is a general object of the present invention to provide a storage device maintaining
25 data when the power source is shut off, which can execute a test process based on test signals by using a test terminal while maintaining high security, in which the above-mentioned problems are eliminated.

A more specific object of the present
30 invention is to provide a storage device maintaining data when the power source is shut off, which can execute a test process based on test signals by using a test terminal and also prevent information stored in the storage device from being illegally read by
35 utilizing the test terminal.

The above first object of the present invention is achieved by a storage device for

maintaining information when power is OFF and being capable of executing a test process based on test signals, including: a test terminal inputting the test signals; an instruction part sending a reading instruction for instructing a memory storing secret data to read out data; a decoding part decoding whether or not the data read out by the memory in response to the data reading instruction is the secret data stored in the memory; a maintaining part maintaining information in a volatile state resulting from the decoding part; and a cutting-off part cutting off the test signals input from the test terminal when the maintaining part maintains information indicating that the secret data is stored.

According to the present invention, based on the result by the decoding part, the test signals input from the test terminal is cut off. Therefore, it is possible to prevent information stored in the storage device from being read by illegal users utilizing the test terminal.

The above first object of the present invention is achieved by a storage device for maintaining information when power is OFF and being capable of executing a test process based on test signals, including: a decoding part gathering a set of data read out by a memory storing secret data in response to an access request and decoding based on the set of data whether or not the secret data is stored. a maintaining part maintaining information in a volatile state resulting from the decoding part; and a cutting-off part cutting off the test signals input from a test terminal when the maintaining part maintains information indicating that the secret data is stored.

According to the present invention, when the secret data is stored, the test process is prohibited by cutting off the test signals.

Therefore, it is possible to prevent information stored in the storage device from being read by illegal users utilizing the test terminal.

The above first object of the present invention is achieved by a storage device for maintaining information when power is OFF and being capable of executing a test process based on test signals, including: a maintaining part maintaining, in a volatile state, information indicating that an access request is conducted to a memory storing secret data; and a cutting-off part cutting off the test signals input from a test terminal when the maintaining part maintains the information indicating that the access request is conducted to the memory storing secret data.

According to the present invention, when the access request is conducted to the memory, the test process is prohibited by cutting off the test signals. Therefore, it is possible to prevent information stored in the storage device from being read by illegal users utilizing the test terminal.

BRIEF DESCRIPTION OF THE DRAWINGS

Other objects, features and advantages of the present invention will become more apparent from the following detailed description when read in conjunction with the accompanying drawings, in which:

FIG.1 is a diagram showing a principle configuration of a storage device according to a first embodiment of the present invention;

FIG.2 is a diagram showing an application of the storage device according to the first embodiment of the present invention;

FIG.3 is a schematic diagram showing an operation between a host device and a storage device controller according to the present invention;

FIG.4 is a diagram showing a security part

according to the first embodiment of the present invention;

FIG.5 is a diagram showing a sequencer of the security part according to the first embodiment
5 of the present invention;

FIG.6 is a diagram showing a security part according to a second embodiment of the present invention;

FIG.7 is a diagram showing a security part
10 according to a third embodiment of the present invention;

FIG.8 is a diagram showing a configuration of a sequencer according to the third embodiment of the present invention;

FIG.9 is a diagram showing a security part
15 according to a fourth embodiment of the present invention; and

FIG.10A is a flow chart for explaining a process of the storage device controller in the configuration in FIG.4 according to the first
20 embodiment of the present invention and FIG.10B is a flow chart for explaining a process of the storage device controller in the configuration in FIG.7 according to the first embodiment of the present
25 invention.

DESCRIPTION OF THE PREFERRED EMBODIMENTS

FIG.1 is a diagram showing a principle configuration of a storage device according to a
30 first embodiment of the present invention.

FIG.1 shows a storage device 1 according to the present invention that can maintain data when the power source is shut off and execute a test process based on a test signal input from a test
35 terminal.

The storage device 1 according to the present invention includes a secret data storing part

10, circuit parts 11-i ($i = 1$ through n), a test input I/F (interface) part 12, a cutting-off part 13, an instruction part 14, a decoding part 15 and a maintaining part 16.

5 The secret data storing part 10 stores secret data including cipher keys. When there is no secret data to be stored, data that is different from any secret data is stored as initial data. When
10 secret data is stored and a data area other than the secret data area storing the secret data is provided, the secret data storing part 10 may store data indicating a presence of secret data in the other data area.

 The circuit parts 11-i ($i = 1$ through n)
15 read the secret data from the secret data storing part 10 and execute a predetermined process by using the secret data. The test input I/F part 12 sends test signals, which are received from a test terminal, to the circuit parts 11-i via the cutting-off part 13.
20 The cutting-off part 13 cuts off test signals from the test input I/F part 12.

 The instruction part 14 sends a data reading instruction to the secret data storing part 10. The decoding part 15 determines by decoding data
25 read from the secret data storeing part 10 whether or not the secret data is stored. The maintaining part 16 maintains in a volatile state a decryption result produced by the decoding part 15.

 In the storage device 1 configured above,
30 the instruction part 14 sends a data reading instruction to the secret data storing part 10 to read normal data when the power source is turned ON or when the storage device is reset or when a command for processing secret data is received.

35 At the same time, the instruction part 14 sends the secret data storing part 10 a data reading instruction to read the secret data, to read data

other than working data, or to read data indicating the presence of the secret data stored in the data area other than the secret data area.

In response to the instruction from the
5 instruction part 14, when the secret data is stored, the secret data storing part 10 outputs the secret data or an address of the secret data. When the secret data is not stored the secret data storing part 10 outputs the initial data different from the
10 secret data or data indicating that the secret data is not stored. In response to the output data from the instruction part 14, the decoding part 15 decrypts the output data indicating whether or not the secret data is stored in the secret data storing
15 part 10.

Further in response to the decryption result of the decoding part 15, the maintaining part 16 maintains information indicating whether or not the secret data is stored in the secret data storing
20 part 10. Subsequently, when the maintaining part 16 maintains information indicating that the secret data is stored, the cutting-off part 13 cuts off a test signal input from the test input I/F part 12.

As mentioned above, in the storage device
25 1 according to the present invention, when the secret data storing part 10 stores the secret data, the test signals are cut off. Therefore, the storage device 1 can maintain high security substantially equivalent to that maintained by a conventional storage device
30 not including a test terminal. In addition, it is possible to execute a test to improve the quality of the storage device according to the present invention.

On the other hand, in the storage device 1 according to the present invention, when an access
35 request is done for the secret data storing part 10, the decoding part 15 obtains data that is read by the secret data storing part 10 responding to the access

request and decrypts the obtained data whether or not the secret data is stored in the secret data storing part 10.

In response to the decryption result of the decoding part 15, the maintaining part 16 maintains information indicating whether or not the secret data is stored in the secret data storing part 10. Subsequently, the cutting-off part 13 cuts off the test signal input from the test input I/F part 12 when the maintaining part 16 maintains information indicating an address of the secret data.

But alternatively, when the access request is done for the secret data storing part 10, the maintaining part 16 may maintain information indicating that the access request is done. And, the cutting-off part 13 may immediately cut off the test signal input from the test terminal.

As mentioned above, in the storage device 1 according to the present invention, the access request for the secret data storing part 10 is detected. After that, the test signal is cut off. Therefore, the storage device 1 can maintain high security substantially equivalent to that maintained by the conventional storage device not including a test terminal. In addition, it is possible to execute a test to improve quality of the storage device according to the present invention.

FIG.2 is a diagram showing an application of the storage device according to the first embodiment of the present invention.

In FIG.2, a storage device 20 embodies the present invention and a host device 30 uses the storage device 20.

The storage device 20 according to the present invention includes a flash memory 40 and a storage device controller 50. The host device 30 starts to communicate with the storage device 20 by

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stores the random number in the working storage area of the controller memory 56.

When the encrypting/decrypting circuit 570 receives the random number from the random number generating circuit 571, the encrypting/decrypting circuit 570 reads one cipher key indicated by the random number from the cipher key storage area of the controller memory 56 and encrypts the read cipher key by using the random number provided and then sends the encrypted cipher key as cipher text to the host device 30.

When receiving the cipher text from the storage device controller 50, the host device 30 obtains the cipher key as plain text the same as the encrypting/decrypting circuit 570 read, by decrypting the cipher text. The host device 30 encrypts data necessary to reply to the storage device controller 50, by using the cipher key so as to make cipher text.

When receiving the cipher text from the host device 30, the encrypting/decrypting circuit 570 decrypts the cipher text by using the same cipher key.

As mentioned above, the storage device controller 50 sends or receives cipher text to/from the host device 30 by a cipher key used as a shared key. However, in a case of an authentication, it is required to communicate by cipher text using a plurality of cipher keys to realize higher security. In this case, the random number generating circuit 571 retrieves a previous random number stored in the working storage area of the controller memory 56 and generates a next random number based on the previous random number so as to avoid generating the previous random number again. Thus, the random number generating circuit 571 can generate a number at random.

In order to ensure the quality of the storage device 20 having the storage device

controller 50 capable of processing as mentioned above, it is required to test whether or not the storage device controller 50 performs as designed. However, if the storage device controller 50 can
5 perform this function, it is possible for an illegal user to steal the cipher keys by utilizing the function.

Thus, in order to eliminate this disadvantage, the security part 58 is provided in the
10 storage device controller 50 as shown in FIG.2.

FIG.4 is a diagram showing the security part 58 according to the first embodiment of the present invention. In FIG. 4, parts that are the same as those shown in FIG.2 or FIG.3 are given the
15 same reference numbers.

In FIG.4, the security part 58 includes a sequencer 580, a test input interface 581, a test selecting part 582, an output part 583, a register 584, a decoder 585 and a control flag latching
20 circuit 586.

The sequencer 580 is executed by power ON and executes an entire process. The test input interface 581 conducts test signals input from the test terminal and decodes the test signals so as to
25 execute a test function corresponding to the test signals.

The test selecting part 582 determines to cut off test signals output from the test input interface 581 based on a control flag latched by the
30 control flag latching circuit 586. The output part 583 outputs the test signals to the test output terminal.

The register 584 maintains data retrieved from the controller memory 56. The data is the
35 cipher key when the cipher key is stored or the initial data when the cipher key is not stored.

The decoder 585 determines whether or not

the data stored in the register 584 is the cipher key, by decoding the data stored in the register 584. The control flag latching circuit 586 controls the test selecting part 582 by latching a result decoded from the decoder 585.

FIG.5 is a diagram showing a sequencer of the security part according to the first embodiment of the present invention.

As shown in FIG.5, the sequencer 580 includes a sequencer operation flag ON part 5800, a sequence counter 5801, a sequencer end-signal generating part 5802, a memory address generating part 5803, a read-signal generating part 5804 and a register store-signal generating part 5805.

The sequencer operation flag ON part 5800 turns ON an operation flag when power is turned ON. The sequence counter 5801 increments a counter while the operation flag is ON. When the counter reaches a predetermined value, the sequence counter 5801 executes the memory address generating part 5803, the read-signal generating part 5804 and the register store-signal generating part 5805. The sequencer end-signal generating part 5802 generates an end-signal to turn OFF the operation flag when the counter of the sequence counter 5801 reaches a maximum value.

The memory address generating part 5803 generates a memory address indicating the cipher key stored in the controller memory 56. The read-signal generating part 5804 generates a read-signal indicating to read data from the controller memory 56. The register store-signal generating part 5805 generates a register store-signal as a timing signal to store in the register 584.

The security part 58 configured as described above can prevent information stored in the storage device 20 from being read by illegal users.

That is, the sequencer 580 provided in the security part 58 starts the sequence counter 5801 to count when power is turned ON. The sequence counter 5801 executes the memory address generating part 5803 to generate a memory address indicating the cipher key in the controller memory 56. Subsequently, the read-signal generating part 5804 is executed to generate a read-signal indicating to read data from the controller memory 56.

10 In response to the generated memory address and read-signal, the controller memory 56 reads data, for example, 16 bytes of data from the indicated memory address. That is, the cipher key is read when the cipher key is stored or the initial data is read when the cipher key is not stored.

Thereafter, the sequencer 580 generates a register store-signal to be a store-timing signal for the register 584 by executing the register store-signal generating part 5805.

20 In response to the register store-signal, the register 584 maintains the data read from the controller memory 56.

As mentioned, when the data read from the controller memory 56 is stored in the register 584, the decoder 585 decodes the data so as to determine whether the data is the cipher key or the initial data. Based on the result of the decoder 585, for example, the control flag latching circuit 586 latches "1" into the control flag when the data maintained in the register 584 is the cipher key or "0" into the control flag when the data maintained in the register 584 is the initial data.

Based on the control flag latched by the control flag latching circuit 586, the test selecting part 582 cuts off the test signal output from the test input I/F part 581 to prevent executing the test function when the data maintained by the register 584

memory address generating part 5803 generates a memory address to read all data other than the working data from the controller memory 56.

In this case, the register 584

5 sequentially maintains data read from the controller memory 56. Accordingly, a circuit may be provided to prohibit the register 584 from maintaining data when the control flag latching circuit 586 latches the control flag indicating that the cipher key is read.

10 As described above, when no cipher key is stored in the cipher key storage area of the controller memory 56, predetermined initial data such as all zero data, which is not used as a cipher key, is stored in the cipher key storage area of the
15 controller memory 56.

Thus, it is possible to determine whether or not the cipher keys are stored. However, the user maker may not use the initial data determined by the maker of the storage device 20.

20 In this case, the maker designs the storage device 20 such that initial data determined by the user maker is used.

Or, the user maker may not use the initial data determined by the storage device maker and may
25 not require any specific initial data. In this case, the storage device maker may request the user maker to write data indicating at least one address of cipher keys in a special storage area of the working storage area of the controller memory 56 when the
30 user maker stores the cipher keys. The storage device 20 may be configured such that when the data written in a special storage area is read, the decoder 585 decodes the data to determine whether or not the cipher keys are stored.

35 In the first embodiment in FIG.4, when the power source is turned on, it is determined whether or not the cipher keys are stored in the controller

memory 56. Based on the result, the control flag latching circuit 586 latches the control flag. In addition, when the controller memory 56 is reset, it is determined whether or not the cipher keys are stored in the controller memory 56. Based on the result, the control flag latching circuit 586 latches the control flag. Further, the same process may be carried out at other times.

FIG.6 is a diagram showing a security part according to a second embodiment of the present invention. In FIG.6, parts that are the same as those shown in the previously described figures are given the same reference numbers and the explanation thereof will be omitted.

For example, as shown in FIG.6, a command interpreting part 587 is provided in the security part 58 to interpret a command. When the command interpreting part 587 detects a command for processing the cipher keys, the command interpreting part 587 determines whether or not the cipher keys are stored in the controller memory 56. Based on the determination result, the control flag latching circuit 586 latches the control flag.

FIG.7 is a diagram showing a security part according to a third embodiment of the present invention. In FIG.7, parts that are the same as those shown in the previously described figures are given the same reference numbers and the explanation thereof will be omitted.

In the first embodiment described in FIG.4, in a case in which the cipher keys are stored in the controller memory 56 when the power source is ON, since it is prohibited to transfer in the test mode, it is possible to prevent information stored in the storage device 20 from being read by illegal users. In the third embodiment in FIG.7, when the encrypting/decrypting circuit 570 reads the cipher

keys, the test selecting part 582 cuts off the test signals output from the test input I/F part 581. That is, a current working test process is cancelled in the test mode or transferring from the normal mode to the test mode is prohibited.

Generally, when the encrypting/decrypting circuit 570 reads the cipher keys, it is possible for illegal users to read the cipher keys by utilizing the test function. However, the storage device 20 according to the third embodiment can eliminate this disadvantage.

In the third embodiment, the sequencer 580 includes the register store-signal generating part 5805 only as shown in FIG.8. When the encrypting/decrypting circuit 570 outputs an access signal for the cipher keys stored in the controller memory 56 by using the register store-signal generating part 5805, the encrypting/decrypting circuit 570 generates a register store-signal to be a store-timing signal of the register 584.

In the configuration according to the third embodiment in FIG.7, when the encrypting/decrypting circuit 570 sends the access signal for accessing the cipher keys to the controller memory 56, the sequencer 580 generates the register store-signal to be the store-timing signal of the register 584 by executing the register store-signal generating part 5805.

In response to the register store-signal, the register 584 maintains one cipher key randomly read by the encrypting/decrypting circuit 570.

When the cipher key is maintained in the register 584, the decoder 585 decodes the data maintained in the register 584 so as to determine whether or not the data is the cipher key. Subsequently, based on the determination result, the control flag latching circuit 586 latches for example

"1", which indicates that the data maintained in the register 584 is the cipher key, into the control flag.

Based on the control flag latched by the control flag latching circuit 586, the test selecting
5 part 582 cuts off the test signals output from the test input I/F part 581 to prohibit from executing the test function.

In this approach, the security part 58
cancels a current working test process in the test
10 mode or prohibits transferring from the normal mode to the test mode. Therefore, it is possible to be certain of preventing information including the cipher keys stored in the storage device 20 from being read illegally by utilizing the test function.

15 In the third embodiment in FIG.7, by maintaining the cipher key read from the encrypting/decrypting circuit 570 in the register 584, the control flag latching circuit 586 latches the control flag to cut off the test signals. But
20 alternatively, as shown in FIG.9, which is a diagram showing a security part according to a fourth embodiment of the present invention, in response to the access signal output from the encrypting/decrypting circuit 570, the sequencer 580
25 controls the control flag latching circuit 586 to latch the control flag in order to cut off the test signals.

FIG.10A is a flow chart for explaining a process of the storage device controller in the
30 configuration in FIG.4 according to the first embodiment of the present invention.

In FIG.10A, when the power source is turned on, the storage device controller 50 reads data from the cipher key storage area of the
35 controller memory 56 (step ST1). When the read data does not indicate the reset data, that is, when the read data is the cipher key, the test signals are cut

off and the test process is prohibited (steps ST2 and ST3). On the other hand, when the read data is reset data, it is allowed to input test signals and the test process is executed (step ST4).

5 In this configuration of the storage device 20, it is prohibited to transfer to the test mode when the cipher keys are stored in the controller memory 56. Therefore, it is possible to be certain to prevent the cipher keys stored in the
10 storage device 20 from being read illegally by utilizing the test function.

FIG.10B is a flow chart for explaining a process of the storage device controller in the configuration in FIG.7 according to the first
15 embodiment of the present invention.

In FIG.10B, when the encrypting/decrypting circuit 570 outputs the access request to access the cipher keys, the storage device controller 50 cuts off the test signals. Thus, the test process can be
20 prohibited or a working test process can be canceled.

In this configuration of the storage device 20, when the cipher key is read from the controller memory 56, it is possible to prevent transferring to the test mode or to immediately
25 cancel the test mode. Therefore, it is possible to be certain in preventing the cipher keys stored in the storage device 20 from being read illegally by utilizing the test function.

The embodiments described above are not
30 limited to protect the cipher keys only.

The present invention is not limited to the specifically disclosed embodiments, variations and modifications, and other variations and modifications may be made without departing from the
35 scope of the present invention.

The present application is based on Japanese Priority Application No. 11-195527 filed on

July 9, 1999, the entire contents of which are hereby incorporated by reference.

CONFIDENTIAL

WHAT IS CLAIMED IS:

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1. A storage device for maintaining information when power is OFF and being capable of executing a test process based on test signals, comprising:

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10          a test terminal inputting the test
          signals;
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an instruction part sending a read out instruction for instructing a memory storing secret data to read out data;

15 a decoding part decoding whether or not
the data read out by the memory in response to the
data reading instruction is the secret data stored in
the memory;

a maintaining part maintaining information
20 in a volatile state resulting from the decoding part;
and

a cutting-off part cutting off the test signals input from the test terminal when the maintaining part maintains information indicating
25 that the secret data is stored.

30 2. The storage device as claimed in claim
1, wherein said read out instruction sent by said
instruction part is a secret data read out
instruction for instructing the memory storing secret
data to read out the secret data.

35

3. The storage device as claimed in claim
1, wherein said read out instruction sent by said
instruction part is a data read out instruction for
5 instructing the memory storing secret data to read
out all data stored in the memory other than working
data.

10

4. The storage device as claimed in claim
1, wherein said read out instruction sent by said
instruction part is a data read out instruction for
15 instructing the memory storing secret data to read
out data indicating a presence of the secret data
stored in an area that is not for the secret data.

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5. The storage device as claimed in claim
1, wherein said instruction part sends the read out
instruction when the power is ON.

25

6. The storage device as claimed in claim
30 1, wherein said instruction part sends the read out
instruction when the memory is reset.

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7. The storage device as claimed in claim
1, wherein said instruction part sends the read out

instruction when a command for operating secret data is made.

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8. A storage device for maintaining information when power is OFF and being capable of executing a test process based on test signals, comprising:

10 a decoding part gathering a set of data read out by a memory storing secret data in response to an access request and decoding based on the set of data whether or not the secret data is stored.

15 a maintaining part maintaining information in a volatile state resulting from the decoding part; and

a cutting-off part cutting off the test signals input from a test terminal when the

20 maintaining part maintains information indicating that the secret data is stored.

25

9. A storage device for maintaining information when power is OFF and being capable of executing a test process based on test signals, comprising:

30 a maintaining part maintaining, in a volatile state, information indicating that an access request is conducted to a memory storing secret data; and

a cutting-off part cutting off the test

35 signals input from a test terminal when the maintaining part maintains the information indicating that the access request is conducted to the memory

ABSTRACT OF THE DISCLOSURE

In a storage device for maintaining information when power is OFF and being capable of executing a test process based on test signals, a
5 test terminal inputs the test signals and an instruction part sends a read out instruction for instructing a memory storing secret data to read out data. Moreover, a decoding part decodes whether or
10 not the data read out by the memory in response to the data reading instruction is the secret data stored in the memory and a maintaining part maintains information in a volatile state resulting from the decoding part. Furthermore, a cutting-off part cuts
15 off the test signals input from the test terminal when the maintaining part maintains information indicating that the secret data is stored.

FIG. 1

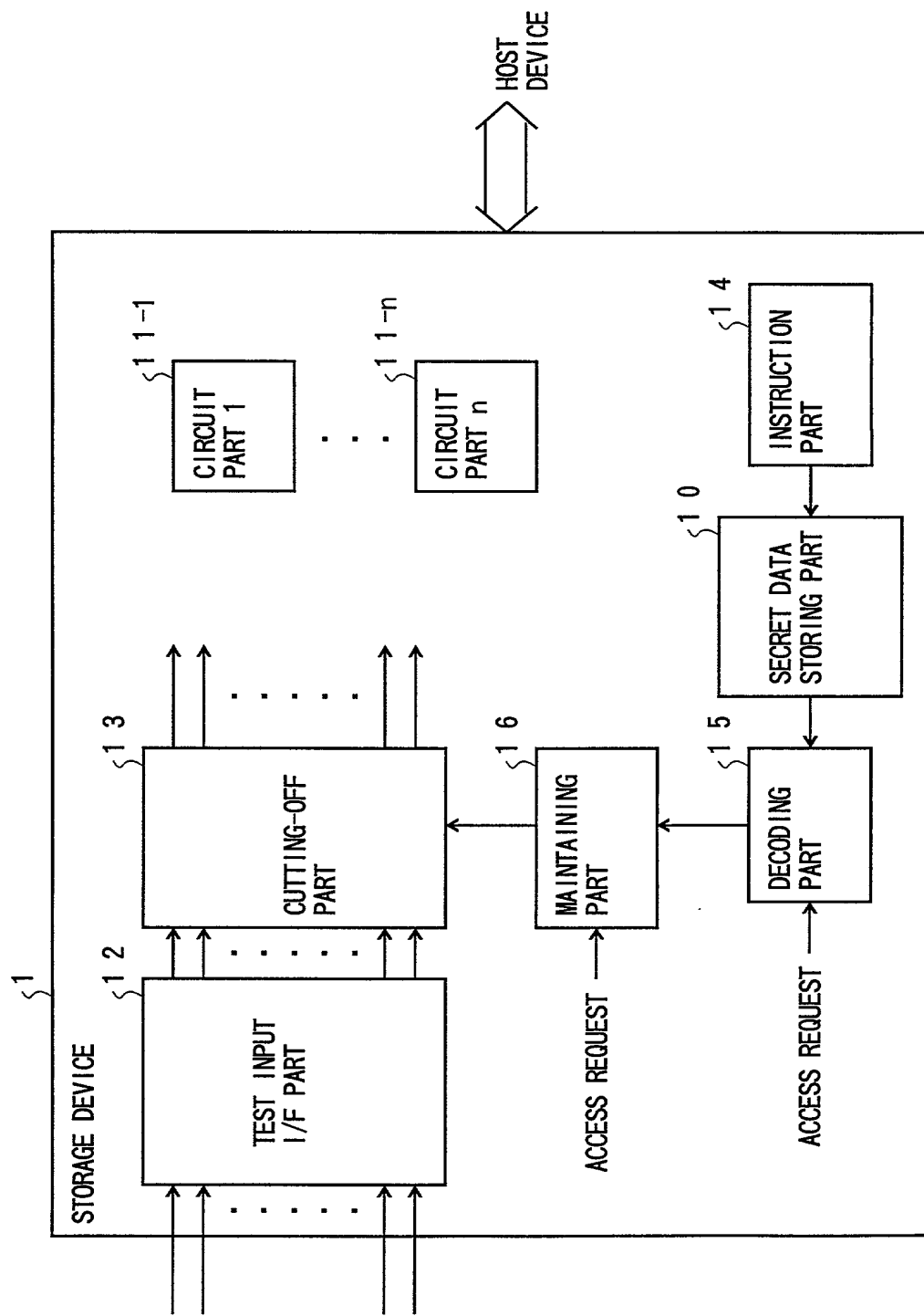


FIG. 2

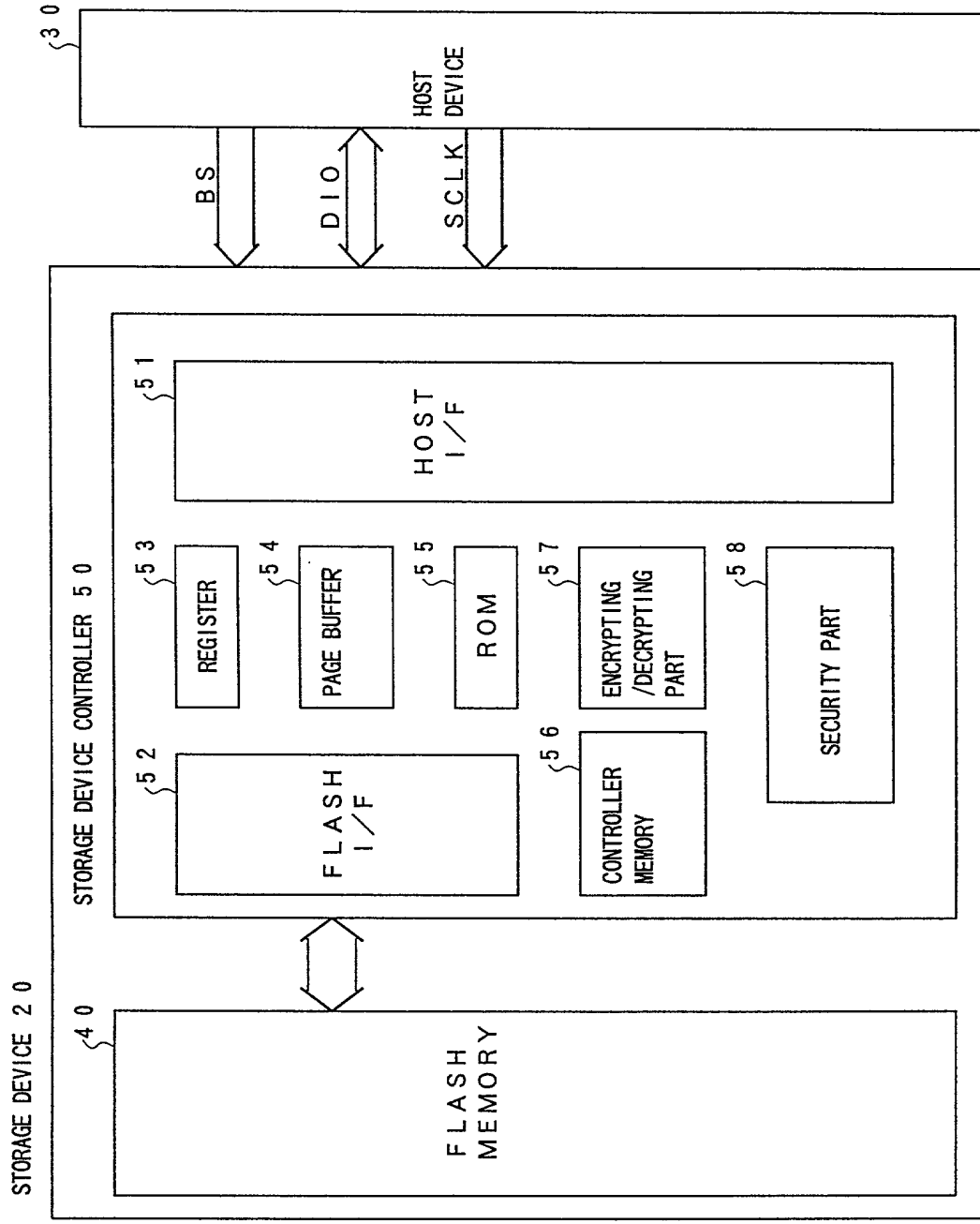


FIG. 3

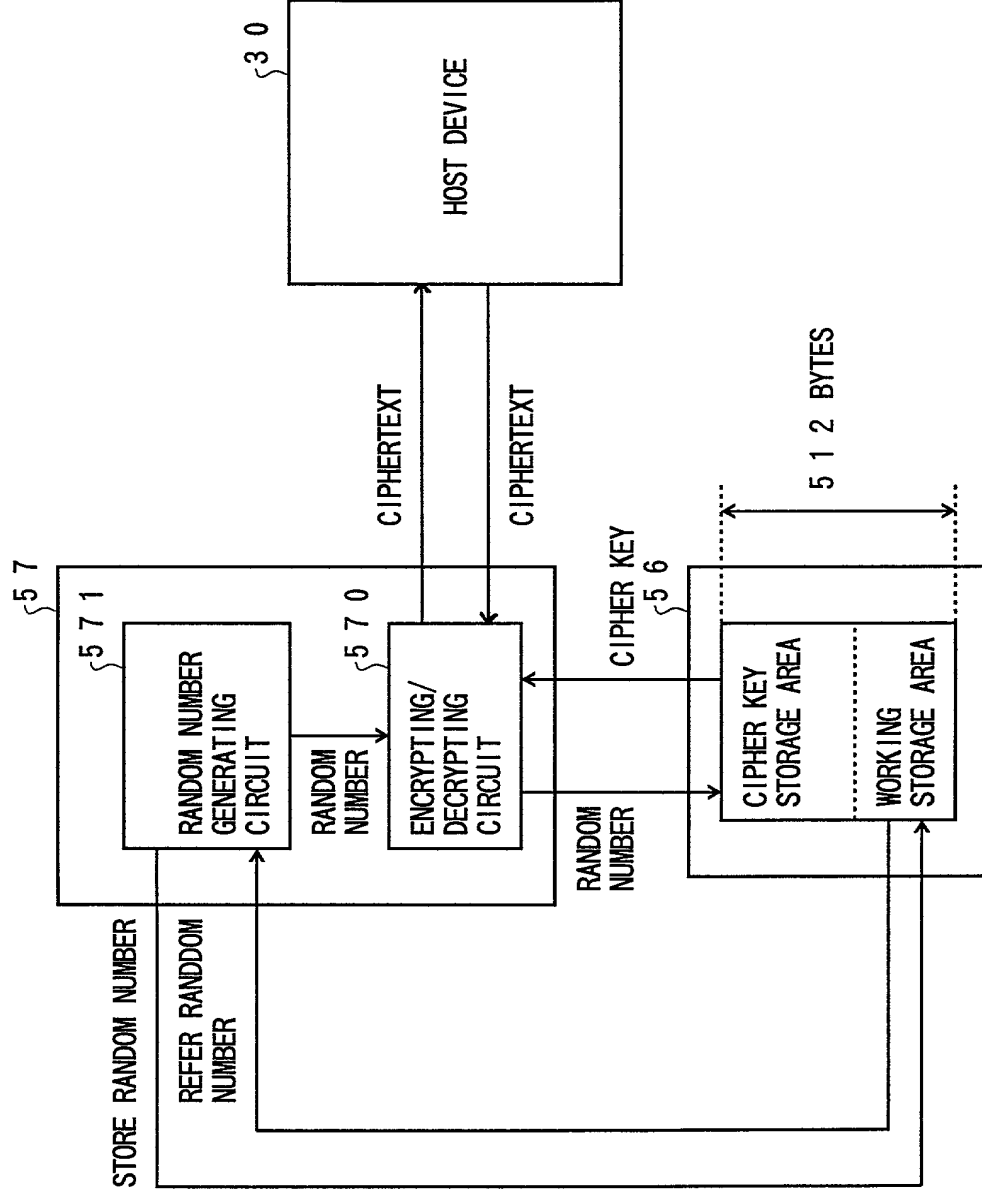


FIG. 4

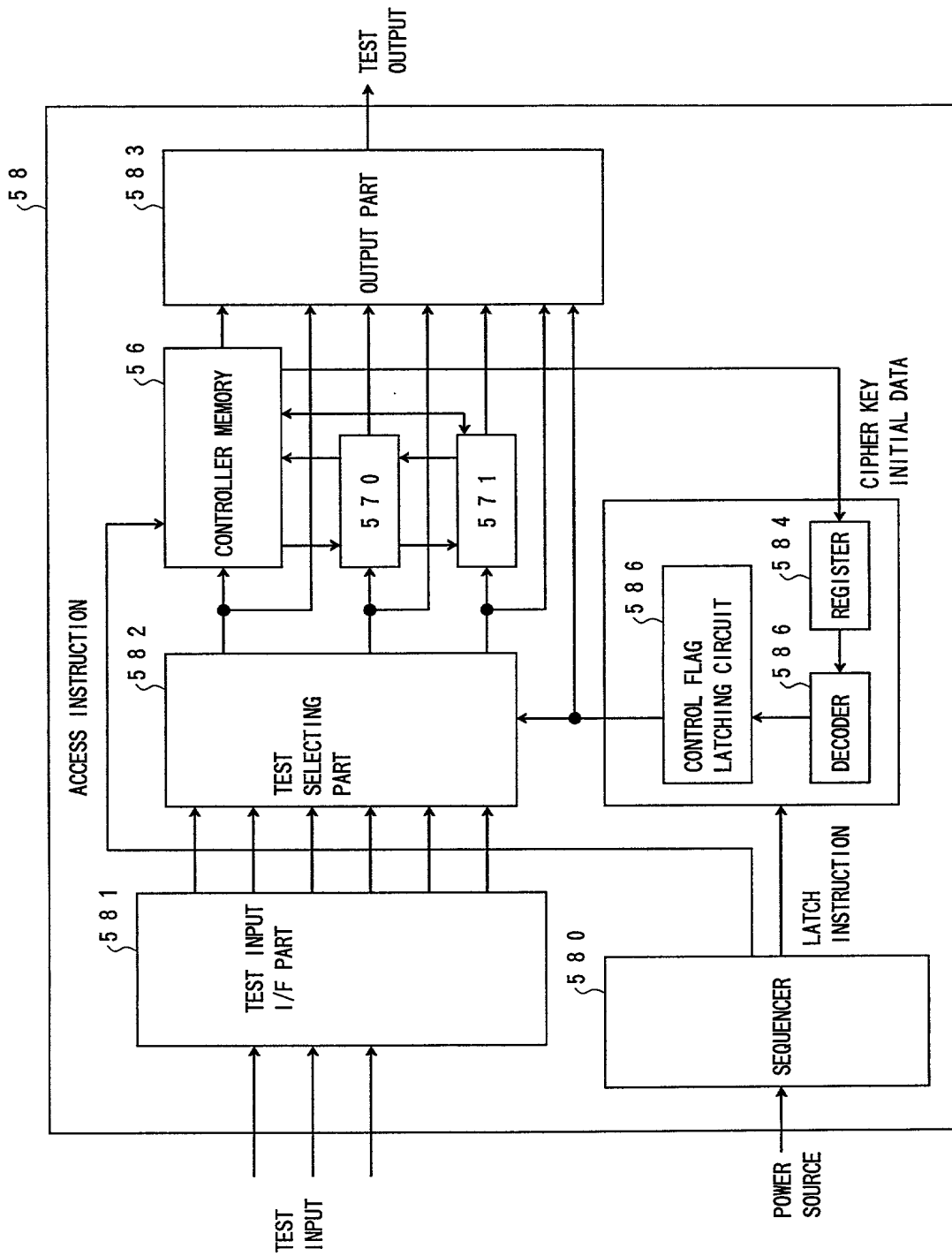


FIG. 5

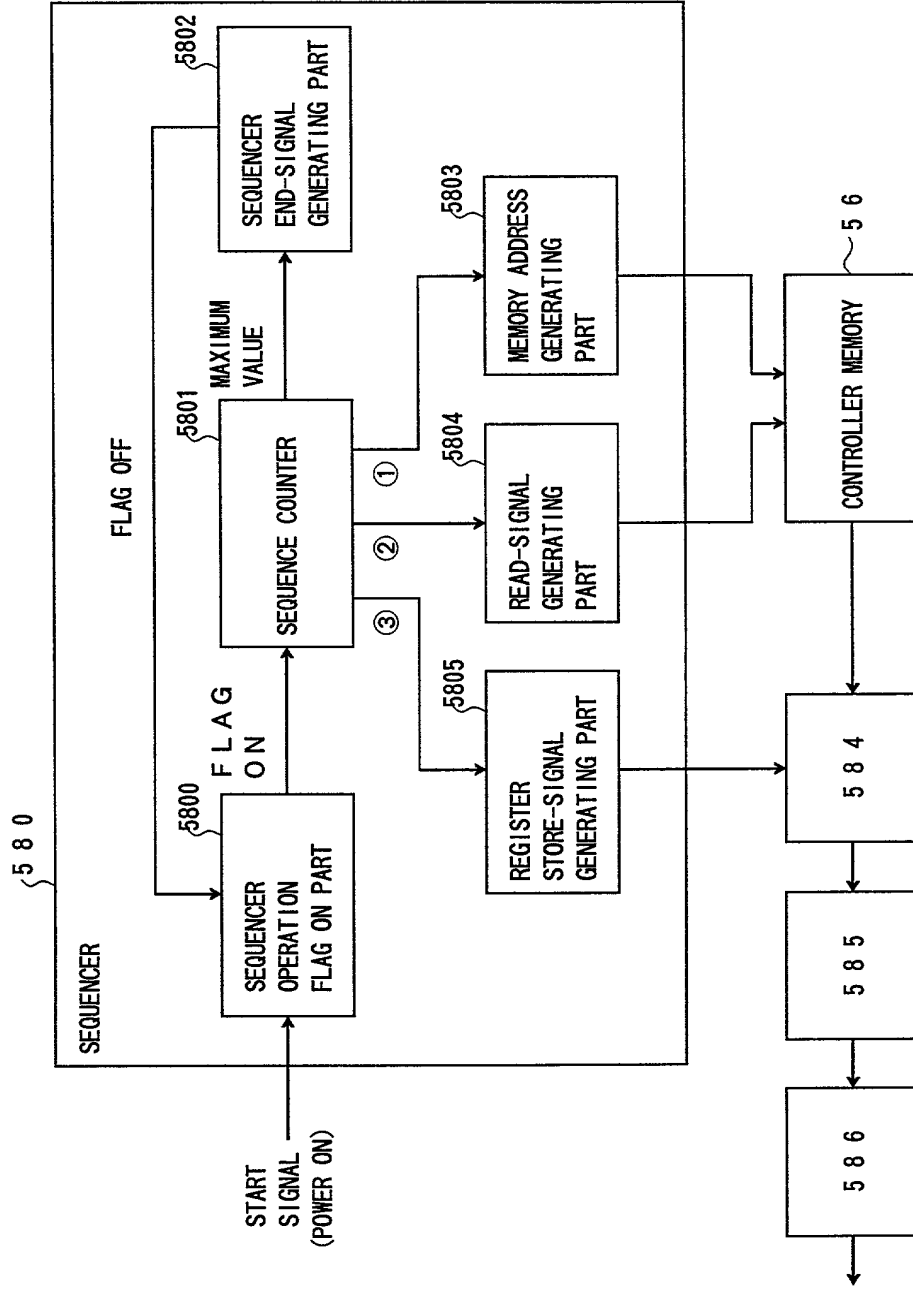


FIG. 6

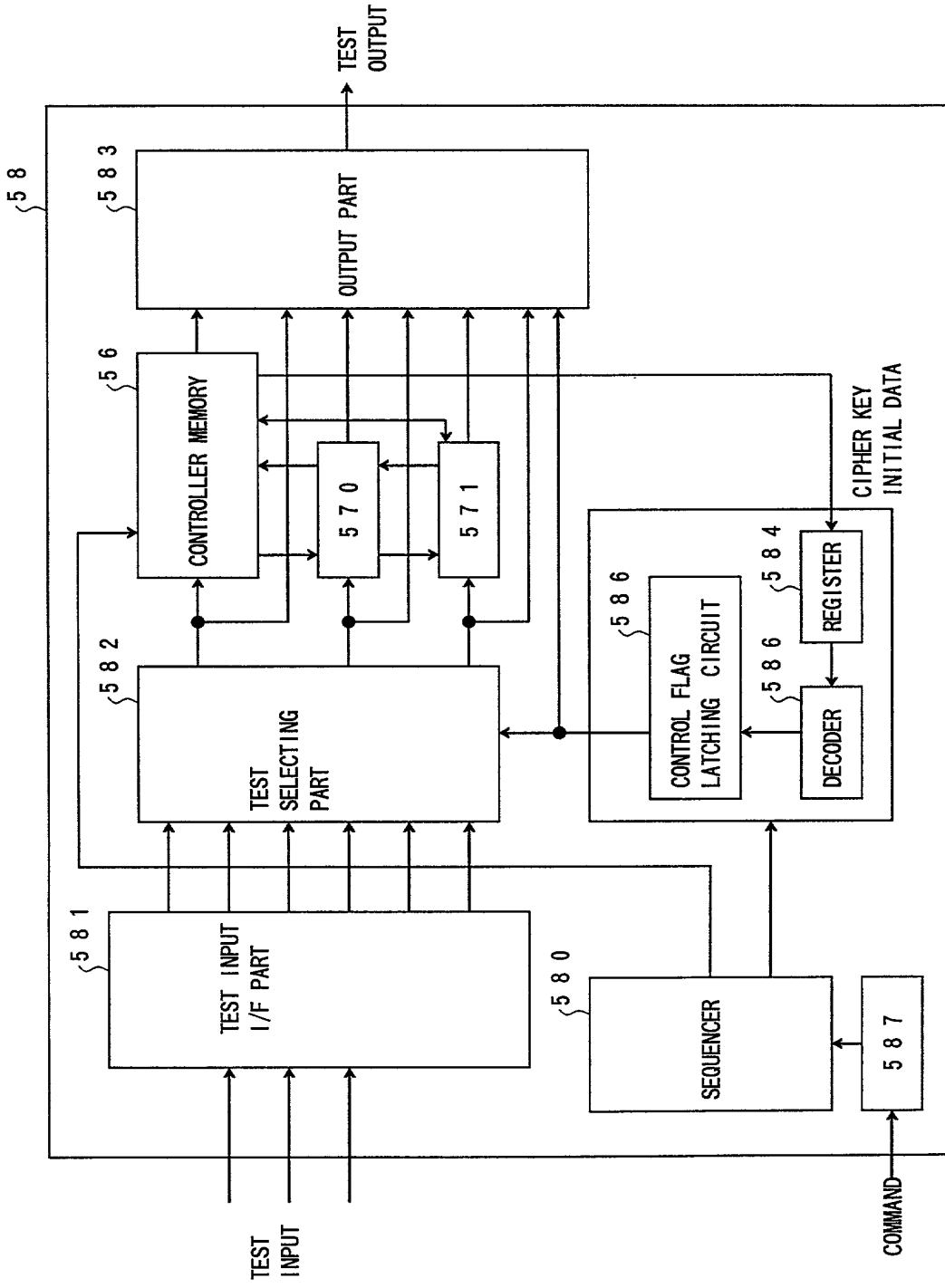
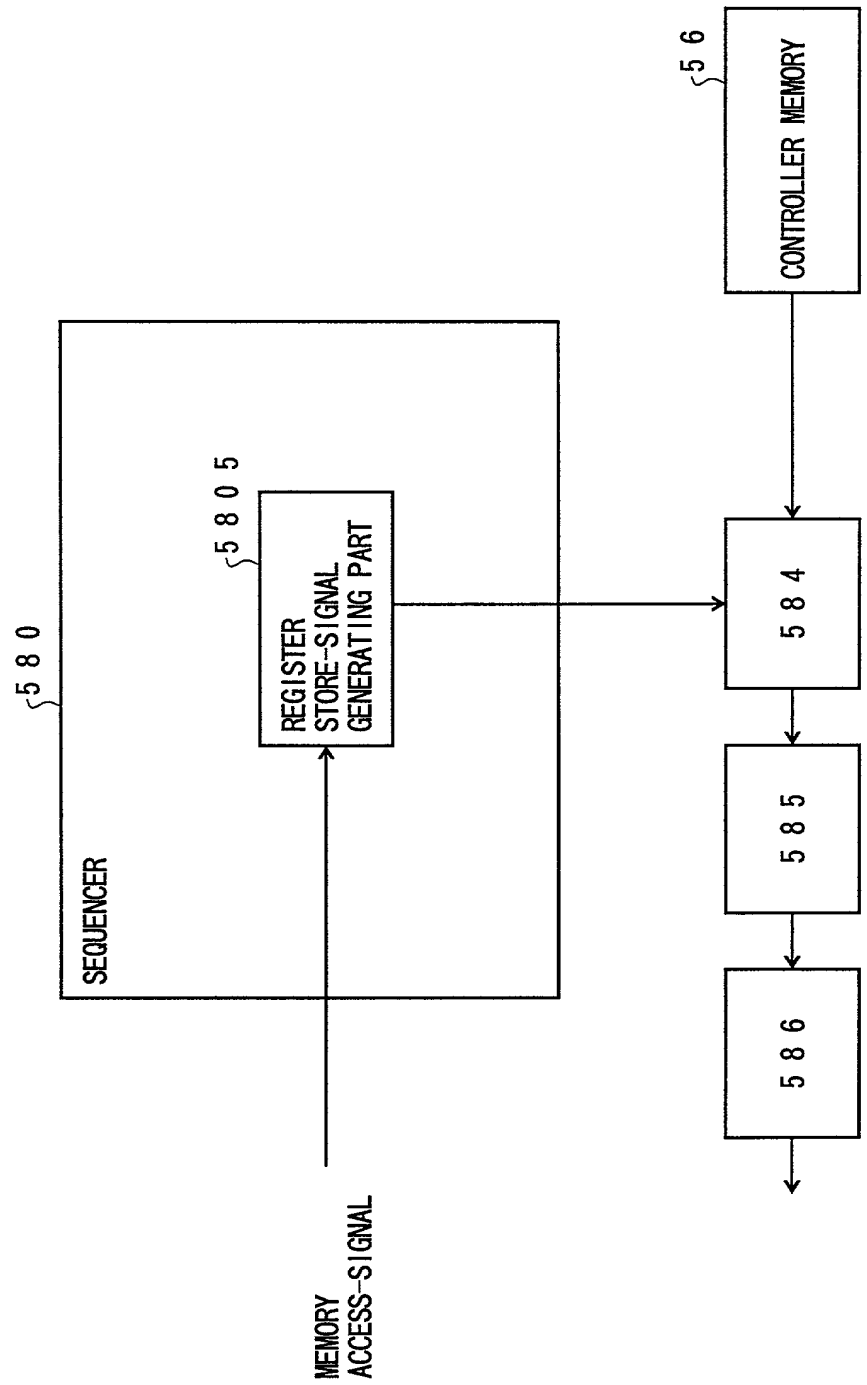


FIG. 8



F I G. 9

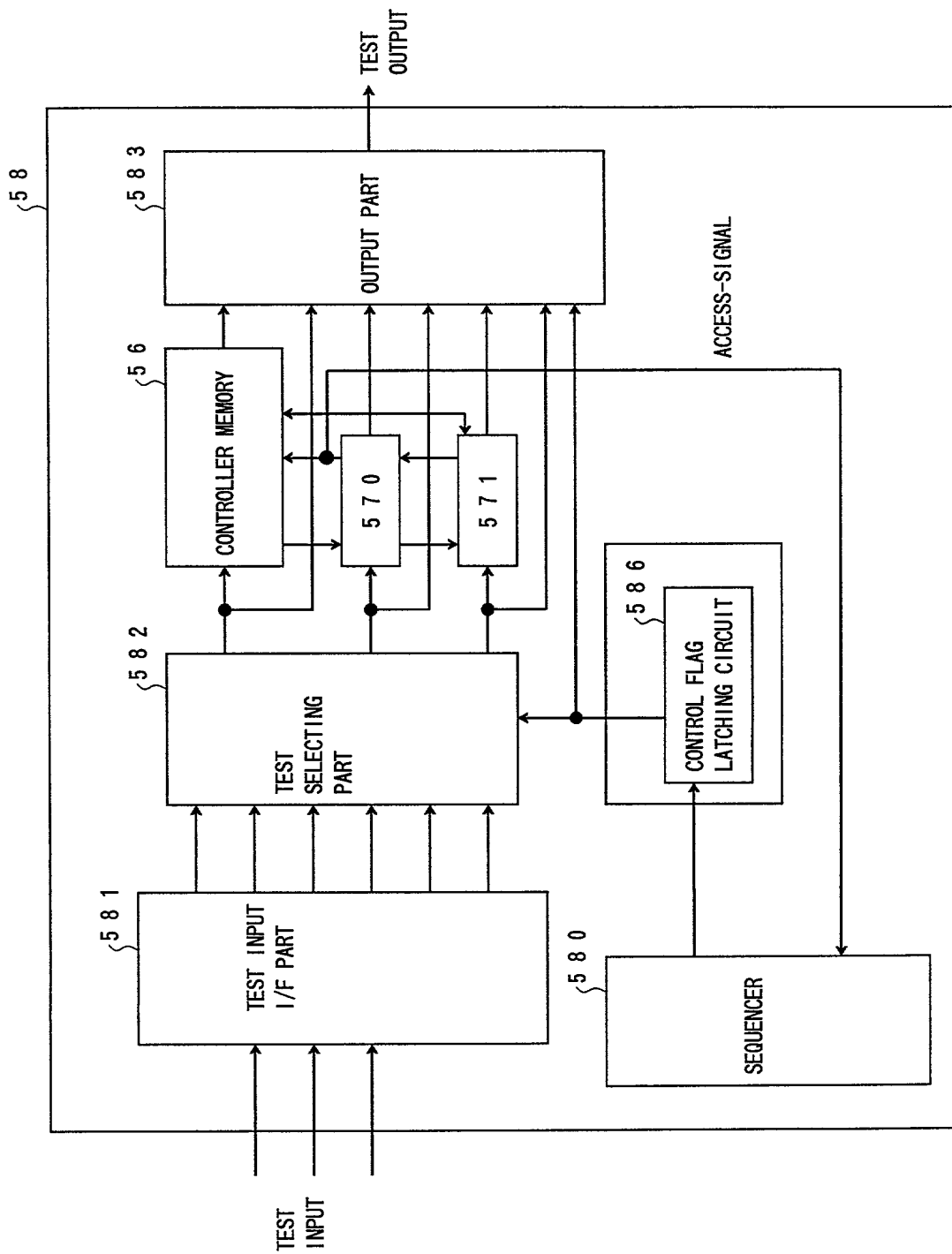


FIG. 10A

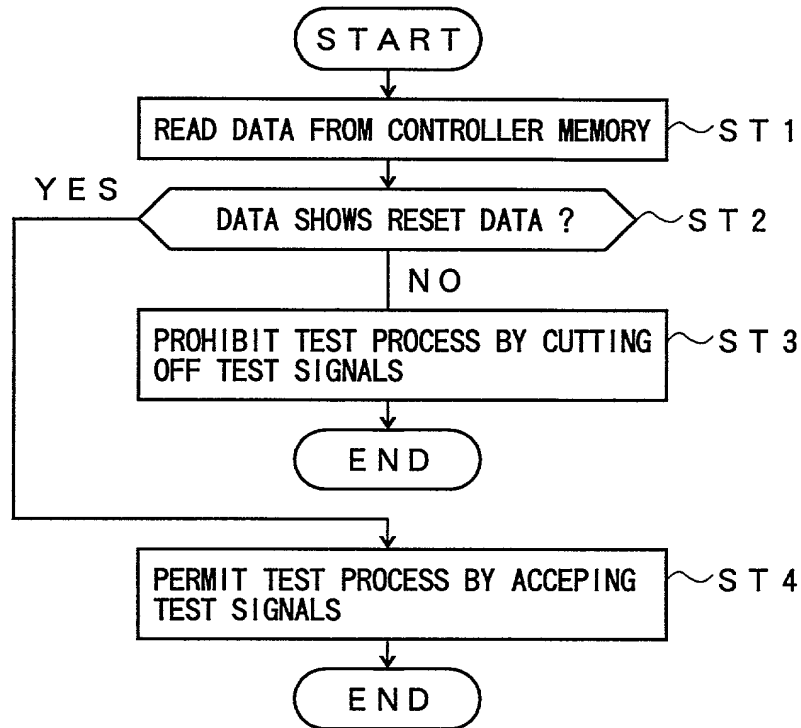
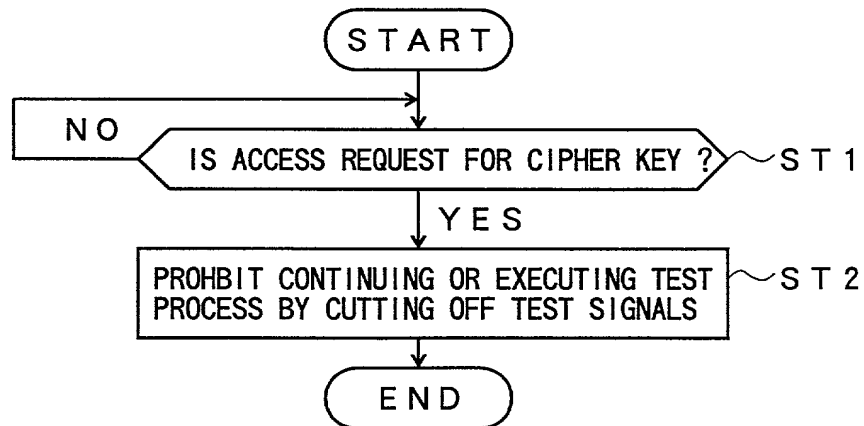


FIG. 10B



Declaration and Power of Attorney For Patent Application

特許出願宣言書及び委任状

Japanese Language Declaration

日本語宣言書

下記の氏名の発明者として、私は以下の通り宣言します。

As a below named inventor, I hereby declare that:

私の住所、私書箱、国籍は下記の私の氏名の後に記載された通りです。

My residence, post office address and citizenship are as stated next to my name.

下記の名称の発明に関して請求範囲に記載され、特許出願している発明内容について、私が最初かつ唯一の発明者（下記の氏名が一つの場合）もしくは最初かつ共同発明者であると（下記の名称が複数の場合）信じています。

I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled

STORAGE DEVICE

上記発明の明細書（下記の欄でx印がついていない場合は、本書に添付）は、

the specification of which is attached hereto unless the following box is checked:

☐ 月 日に提出され、米国出願番号または特許協定条約国際出願番号を _____ とし、
（該当する場合） _____ に訂正されました。

☐ was filed on _____
as United States Application Number or
PCT International Application Number
_____ and was amended on
_____ (if applicable).

私は、特許請求範囲を含む上記訂正後の明細書を検討し、内容を理解していることをここに表明します。

I hereby state that I have reviewed and understand the contents of the above identified specification, including the claims, as amended by any amendment referred to above.

私は、連邦規則法典第37編第1条56項に定義されるとおり、特許資格の有無について重要な情報を開示する義務があることを認めます。

I acknowledge the duty to disclose information which is material to patentability as defined in Title 37, Code of Federal Regulations, Section 1.56.

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私は、米国法典第35編119条(a)-(d)項又は365条(b)項に基づき下記の、米国以外の国の少なくとも一カ国を指定している特許協力条約365(a)項に基づく国際出願、又は外国での特許出願もしくは発明者証の出願についての外国優先権をここに主張するとともに、優先権を主張している、本出願の前に出願された特許または発明者証の外国出願を以下に、枠内をマークすることで、示しています。

Prior Foreign Application(s)

外国での先行出願

Pat. Appln. No. 11-195527

Japan

(Number)

(Country)

(番号)

(国名)

(Number)

(Country)

(番号)

(国名)

私は、第35編米国法典119条(e)項に基づいて下記の米国特許出願規定に記載された権利をここに主張いたします。

(Application No.)

(Filing Date)

(出願番号)

(出願日)

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(Application No.)

(Filing Date)

(出願番号)

(出願日)

(Application No.)

(Filing Date)

(出願番号)

(出願日)

私は、私自身の知識に基づいて本宣言書中で私が行なう表明が真実であり、かつ私の入手した情報と私の信じていることに基づき表明が全て真実であると信じていること、さらに故意になされた虚偽の表明及びそれと同等の行為は米国法典第18編第1001条に基づき、罰金または拘禁、もしくはその両方により処罰されること、そしてそのような故意による虚偽の表明を行なえば、出願した、又は発明に許可された特許の有効性が失われることを認識し、よってここに上記のごとく宣誓を致します。

I hereby claim foreign priority under Title 35, United States Code, Section 119 (a)-(d) or 365(b) of any foreign application(s) for patent or inventor's certificate, or 365(a) of any PCT International application which designated at least one country other than the United States, listed below and have also identified below, by checking the box, any foreign application for patent or inventor's certificate, or PCT International application having a filing date before that of the application on which priority is claimed.

Priority Not Claimed

優先権主張なし

9/July/1999

(Day/Month/Year Filed)

(出願年月日)

(Day/Month/Year Filed)

(出願年月日)

I hereby claim the benefit under Title 35, United States Code, Section 119(e) of any United States provisional application(s) listed below.

(Application No.)

(Filing Date)

(出願番号)

(出願日)

I hereby claim the benefit under Title 35, United States Code, Section 120 of any United States application(s), or 365(c) of any PCT International application designating the United States, listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States or PCT International application in the manner provided by the first paragraph of Title 35, United States Code Section 112, I acknowledge the duty to disclose information which is material to patentability as defined in Title 37, Code of Federal Regulations, Section 1.56 which became available between the filing date of the prior application and the national or PCT International filing date of application.

(Status: Patented, Pending, Abandoned)

(現況: 特許許可済、係属中、放棄済)

(Status: Patented, Pending, Abandoned)

(現況: 特許許可済、係属中、放棄済)

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

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Japanese Language Declaration

(日本語宣言書)

委任状: 私は下記の発明者として、本出願に関する一切の手続きを米特許庁事務局に対して遂行する弁理士または代理人として、下記の者を指名いたします。(弁理士、または代理人の氏名及び登録番号を明記のこと)

POWER OF ATTORNEY: As a named inventor, I hereby appoint the following attorney(s) and/or agent(s) to prosecute this application and transact all business in the Patent and Trademark Office connected therewith (list name and registration number)

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(第三以降の共同発明者についても同様に記載し、署名をすること)

(Supply similar information and signature for third and subsequent joint inventors.)